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TESTING
CNAS L5772

CE EMC TEST REPORT

for

Product: LED filament lamp
Model:A60-8W(Model list see page 10)
Report No.: PTC25060416601E-EM01

Issued for

Haining Shengchang electric light source technology Co., Ltd
Tanqiao Industrial Park, Yuanhua Town, Haining City, Zhejiang Province

Issued by

Precise Testing & Certification (Guangdong) Co., Ltd.
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Report No.: PTC25060416601E-EM01

1. TEST CERTIFICATION

Product:	LED filament lamp
Model:	A60-8W(Model list see page 10)
Applicant :	Haining Shengchang electric light source technology Co., Ltd
Address:	Tanqiao Industrial Park, Yuanhua Town, Haining City, Zhejiang Province
Manufacturer:	Haining Shengchang electric light source technology Co., Ltd
Address:	Tanqiao Industrial Park, Yuanhua Town, Haining City, Zhejiang Province
Factory:	Haining Shengchang electric light source technology Co., Ltd
Address:	Tanqiao Industrial Park, Yuanhua Town, Haining City, Zhejiang Province
Test Date:	June 06, 2025 to June 18, 2025
Issued Date:	June 25, 2025
Test Voltage:	AC 230V/50Hz
Applicable Standards:	EMC Directive 2014/30/EU EN IEC 55015:2019+A11:2020 EN 61547:2009 EN IEC 61000-3-2:2019+A1:2021 EN 61000-3-3:2013+A1:2019+A2:2021

The above equipment has been tested by Precise Testing & Certification (Guangdong) Co., Ltd. and found compliance with the requirements in the technical standards mentioned above. The test results presented in this report only relate to the product/system tested. The Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Test Engineer:

Technical Manager:



Simon Pu /Manager



2. TEST SUMMARY

EMISSION			
Standard	Item	Result	Remarks
EN IEC 55015:2019+A11:2020	Conducted (Main Port)	PASS	Complied with limit
	Radiated Electromagnetic Disturbance	PASS	Complied with limit
	Radiated Emission	PASS	Complied with limit
EN IEC 61000-3-2:2019+A1:2021	Harmonic current emissions	PASS	Complied with limit
EN 61000-3-3:2013+A1:2019+A 2:2021	Voltage fluctuations & flicker	PASS	Complied with limit

IMMUNITY			
Standard	Item	Result	Remarks
IEC 61000-4-2:2008	ESD	PASS	Complied with the requirements
IEC 61000-4-3:2006+ A1:2007	RS	PASS	Complied with the requirements
IEC 61000-4-4:2004	EFT	PASS	Complied with the requirements
IEC 61000-4-5:2005	Surge	PASS	Complied with the requirements
IEC 61000-4-6:2008	CS	PASS	Complied with the requirements
EN 61000-4-8:1993+A1:2000	PFMF	N/A	N/A
IEC 61000-4-11:2004	Voltage dips & voltage variations	PASS	Complied with the requirements

Note: 1) The test result verdict is decided by the limit of test standard

2) The information of measurement uncertainty is available upon the customer's request.



3. TEST SITE

3.1. TEST FACILITY

Precise Testing & Certification (Guangdong) Co., Ltd.

Address: Building 1, No. 6, Tongxin Road, Dongcheng Street, Dongguan, Guangdong, China.

☆ CNAS Registration No.: CNAS L5772

☆ FCC Registration No.: 790290

☆ A2LA Certificate No.: 4408.01

☆ IC Registration No.: 12191A

3.2. MEASUREMENT UNCERTAINTY

Parameter	U _{lab}	U _{cispr}
Temperature	$\pm 1^{\circ} \text{C}$	-
Humidity	$\pm 5\%$	-
DC and Low Frequency Voltages	$\pm 3\%$	-
Conducted Emission(9KHz-150KHz)	$\pm 3.60\text{dB}$	$\pm 3.80\text{dB}$
Conducted Emission(9KHz-30MHz)	$\pm 3.60\text{dB}$	$\pm 3.40\text{dB}$
Conducted Emission(Control port)	$\pm 3.46\text{dB}$	$\pm 5.00\text{dB}$
Disturbance Power	$\pm 3.68\text{dB}$	$\pm 4.50\text{dB}$
Loop	$\pm 4.02\text{dB}$	$\pm 3.30\text{dB}$
Radiated Emission(30MHz-1GHz)	$\pm 4.76\text{dB}$	$\pm 6.30\text{dB}$
Radiated Emission (1GHz-6GHz)	$\pm 4.44\text{dB}$	$\pm 5.20\text{dB}$
Radiated Emission (6GHz-18GHz)	$\pm 4.44\text{dB}$	$\pm 5.50\text{dB}$

Note 1: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.3. DECISION RULE

1. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.
2. The U_{lab} is less than U_{cispr}, compliance is deemed to occur if no measured



disturbance level exceeds the disturbance limit; non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.

3. For conducted emission test of laboratory have a measurement uncertainty greater than that specified in harmonized standard, this equipment can still be used provided that an adjustment is made follows: any additional uncertainty in the test system over and above that specified in harmonized standard should be used to tighten the test requirements-making the test harder to pass. This procedure will ensure that a test system not compliant with harmonized standard does not increase the probability of passing a EUT that would otherwise have failed a test if a test system compliant with harmonized standard had been used.



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3.4. LIST OF TEST AND MEASUREMENT INSTRUMENTS

3.4.1. For conducted emission at the mains terminals test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
EMI Test Receiver	Rohde&Schwarz	ESCI3	101417	Aug. 15,2024	1 Year
Artificial Mains Network	Rohde&Schwarz	ENV216	101342	Oct. 30,2024	1 Year
ISN	SCHWARZBECK	NTFM8131	00257	Aug. 15,2024	1 Year
Test S/W	Tonscend	JS32-CE/4.0.0.3			

3.4.2. For radiated electromagnetic emission test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
EMI Test Receiver	Rohde&Schwarz	ESCI3	101417	Aug. 15,2024	1 Year
Triple-Loop Antenna	PATCH PANEL	RF300	9138	Aug. 15,2024	1 Year
Test S/W	Tonscend	JS32-CE/4.0.0.3			

3.4.3. For radiated emission test (30MHz-1GHz)

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
EMI Test Receiver	Rohde&Schwarz	ESPI7	101671	Aug. 15,2024	1 Year
Bilog Antenna	SCHWARZBECK	VULB 9168	9168-3355	Sept. 10,2024	1 Year
Preamplifier (low frequency)	SCHWARZBECK	BBV 9745	9745-0013	Mar. 21, 2025	1 Year
Test S/W	Tonscend	JS32-RE/4.0.0.0			

3.4.4. For harmonic current emissions and voltage fluctuations/flicker test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
Harmonics / Flicker	California	CTS/PACS-1-115	1534A00401	Aug. 15,2024	1 Year



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Test System	Instruments				
AC Power Source	California Instruments	3001IX-208-CTS	1534A00401	Aug. 15,2024	1 Year
Test S/W	AMETEK	CTS 4			

3.4.5. For electrostatic discharge immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
ESD Generator	SCHLODER	SESD216	606137	Aug. 15,2024	1 Year

3.4.6. For radio frequency electromagnetic field immunity (R/S) test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
Power meter	Agilent	E4419B	GB42421440	Aug. 15,2024	1 Year
Isotropic Field Probe	Narda	EP-601	611WX80275	Aug. 17,2024	1 Year
Amplifier	SKET	HAP_801000M-250W	201811050	Mar. 21,2025	1 Year
Amplifier	SKET	HAP_0103G-75W	201811051	Aug. 15,2024	1 Year
Amplifier	SKET	HAP_0306G-20W	201811052	Mar. 21,2025	1 Year
Log-periodic Antenna	SKET	ZDSZ-80T1000M-231	SKT231015	Nov. 04,2024	1 Year
Log-periodic Antenna	SKET	ZDSZ-1T6G-232	SKT232079	Nov. 04,2024	1 Year

3.4.7. For electrical fast transient/burst immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
EFT Tester	HTEC	HCOMPACT52	190901	Aug. 15,2024	1 Year
EFT Coupling Clamp	HTEC	HEFT 51-C	1416011	Aug. 15,2024	1 Year



3.4.8. For surge immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
Surge Tester	HTEC	HCWG 71	174302	Aug. 15,2024	1 Year
Surge Tester	HTEC	TCOMB 4	142103	Aug. 15,2024	1 Year
Surge Tester	HTEC	HTSG 70	175002	Aug. 15,2024	1 Year

3.4.9. For injected currents susceptibility test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
C/S Test System	SCHLODER	CDG-6000-25	126A1279/2014	Mar. 21,2025	1 Year
Coupling Decoupling Network	SCHLODER	CDN-M2+3	A2210251/2013	Aug. 15,2024	1 Year
Coupling/decoupling network	SCHLODER	CMCL-20	180901961-0201	Aug. 15,2024	1 Year
Test S/W	SCHLODER	CDG/1.0.0.0			

3.4.10. For power frequency magnetic field immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
Magnetic Field Tester	HTEC	HPFMF	142104	Aug. 15,2024	1 Year

3.4.11. For voltage dips and short interruptions immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Last Cal.	Calibration Interval
Dips Tester	HTEC	HV1P16T	170901	Aug. 15,2024	1 Year



4. EUT DESCRIPTION

Product	LED filament lamp
Model	A60-8W
Additional Model	C35-2W,C35-4W,C35-5W,G45-2W, G45-4W,G45-5W,A60-2W, A60-4W,A60-6W,A60-8W,A60-8W-E27(3000K),ST64-2W,ST64-4W, ST64-6W,ST64-8W,G80-2W,G80-4W,G80-6W,G80-8W,G95-2W, G95-4W,G95-6W,G95-8W,G125-2W, G125-4W, G125-6W,G125-8W, T45-2W,T45-4W,T45-6W,T45-8W,S14-2W,S14-4W, S14-5W, T30-125-2W,T30-125-4W, T30-125-6W,T30-145-2W,T30-145-4W, T30-145-6W,T30-185-2W,T30-185-4W,T30-185-6W,T30-185-8W, T30-225-2W,T30-225-4W,T30-225-6W,T30-225-8W,T30-300-2W, T30-300-4W,T30-300-6W,T30-300-8W,PS160-4W, PS160-6W, PS160-8W,G150-4W,G150-6W,G150-8W,G180-4W, G180-6W, G180-8W,G200-4W, G200-6W,G200-8W,G250-4W,G250-6W, G250-8W,BT180-4W, BT180-6W,BT180-8W,TT75-4W, TT75-6W, TT75-8W,R160-4W, R160-6W,R160-8W,LS200-4W,LS200-6W, LS200-8W,ZS125-4W, ZS125-6W,NG95-4W, NG95-6W,NG125-4W, NG125-6W,BL125-4W,BL125-6W,BT75-8w,BT75-7w,BT75-6w, BT75-5w,BT75-4w,BIB95-8w, BIB95-7w,BIB95-6w,BIB95-5w, BIB95-4w,BIB125-8w, BIB125-7w,BIB125-6w, BIB125-5w, BIB125-4w,C82407MM,C82409MM
Supplied Voltage	220-240V~, 50/60Hz, 0.45A
Power	N/A.

I/O PORT

I/O PORT TYPES	Q'TY	TESTED WITH
AC Port	1	☒
DC Port	1	☐

Models Difference

Only the model name is different.



5. TEST METHODOLOGY

5.1. TEST MODE

The EUT was tested together with the thereafter additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

The following test mode(s) were assessed.

Test Items		Test Mode
Emission	Conducted Emission	Lighting
	Radiated Electromagnetic Disturbance	Lighting
	Radiated Emission	Lighting
	Harmonic current emissions	Lighting
	Voltage fluctuations & flicker	Lighting
Immunity	ESD	Lighting
	RS	Lighting
	EFT	Lighting
	Surge	Lighting
	C/S	Lighting
	PFMF	N/A
	Dips	Lighting

5.2. EUT SYSTEM OPERATION

1. Set up EUT with the support equipment.
2. Make sure the EUT work normally during the test.



6. SETUP OF EQUIPMENT UNDER TEST

6.1. DESCRIPTION OF SUPPORT UNITS

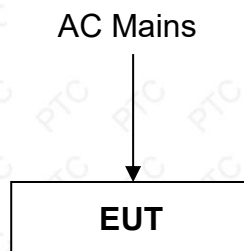
The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

No.	Equipment	Model	Serial No.	FCC ID	Trade Name	Data Cable	Power Cord
1.	N/A	N/A	N/A	N/A	N/A	N/A	N/A

Note: 1) All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

2) Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

6.2. CONFIGURATION OF SYSTEM UNDER TEST



(EUT: LED filament lamp)



7. EMISSION TEST

7.1. CONDUCTED EMISSION MEASUREMENT

7.1.1. LIMITS

FREQUENCY (MHz)	LIMITS(dB μ V)	
	Quasi-peak	Average
0.009-0.05	110	N/A
0.05-0.15	90 – 80	N/A
0.15 - 0.5	66 – 56	56 - 46
0.50 - 5.0	56	46
5.0 - 30.0	60	50

Note: 1) The lower limit shall apply at the transition frequencies.

2) The limit decreases in line with the logarithm of the frequency in the range of 0.15 MHz to 0.5 MHz

7.1.2. TEST PROCEDURES

The EUT and Support equipment, if needed, was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane. When the EUT is floor standing equipment, it is placed on the ground plane, which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane. The EUT should be 0.8 m apart from the AMN, where the mains cable supplied by the manufacturer is longer than 0.8 m, the excess should be folded at the centre into a bundle no longer than 0.4 m, Details please refer to test setup photography.

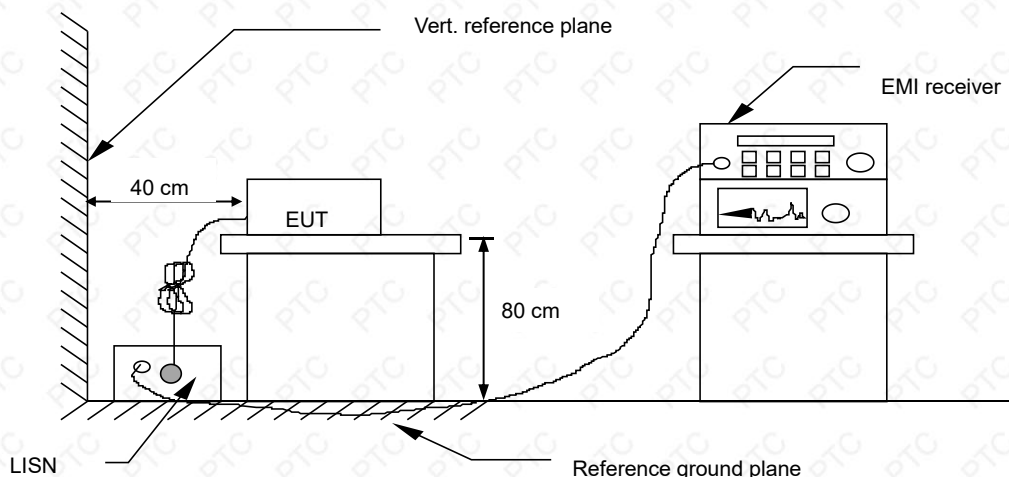
The Receiver scanned from 9 kHz to 30 MHz for emissions in each of the test modes. During the above scans, the emissions were maximized by cable manipulation.

A scanning was taken on the power lines, Line and neutral, recording at least six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. The test data of the worst-case condition(s) was recorded.

The test data of the worst-case condition(s) was recorded.

Note: Test Software Name: Tonscend,JS32-RE/4.0.0.3.

7.1.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.1.4. TEST RESULT

Product name	LED filament lamp	Tested By	CCX
Model	A60-8W	Detector Function	Peak / Quasi-peak/AV
Test Mode	Lighting	6 dB Bandwidth	200 Hz/9 kHz
Environmental Conditions	24.2°C, 55 % RH, 101.5 kPa	Test Result	Pass

Note:

L = Line Line, N = Neutral Line

Freq. = Emission frequency in MHz

Reading level (dBμV) = Receiver reading

Corr. Factor (dB) = attenuator + Cable loss

Level (dBμV) = Reading level (dBμV) + Corr. Factor (dB)

Limit (dBμV) = Limit stated in standard

Over Limit (dB) = Level (dBμV) – Limit (dBμV)

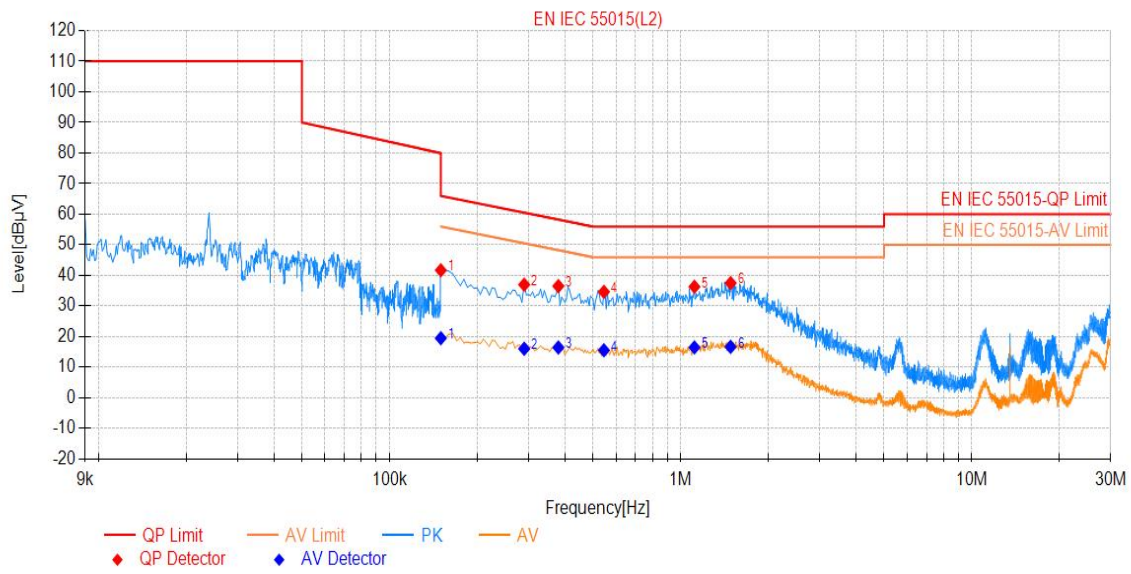
QP = Quasi-Peak

AV = Average



Please refer to the following diagram:

Line:

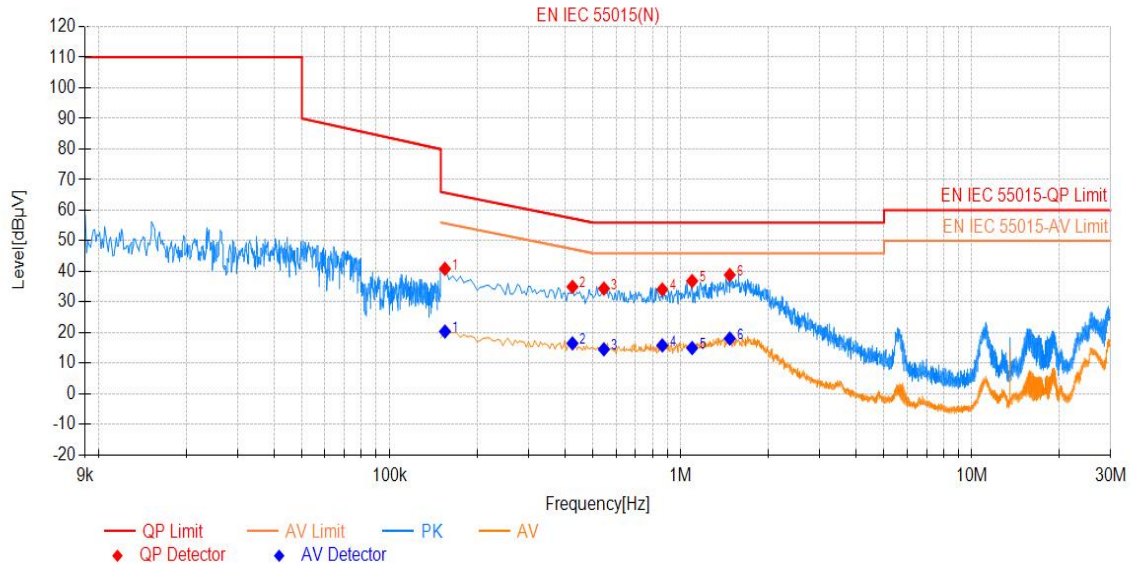


Final Data List

NO.	Freq. [MHz]	QP Reading [dBμV]	Factor [dB]	QP Value [dBμV]	QP Limit [dBμV]	QP Margin [dB]	AV Reading [dBμV]	AV Value [dBμV]	AV Limit [dBμV]	AV Margin [dB]	Verdict
1	0.150	31.89	9.81	41.70	66.00	24.30	9.69	19.50	56.00	36.50	PASS
2	0.290	27.20	9.81	37.01	60.52	23.51	6.23	16.04	50.52	34.48	PASS
3	0.380	26.72	9.81	36.53	58.28	21.75	6.65	16.46	48.28	31.82	PASS
4	0.545	24.85	9.81	34.66	56.00	21.34	5.75	15.56	46.00	30.44	PASS
5	1.115	26.49	9.83	36.32	56.00	19.68	6.67	16.50	46.00	29.50	PASS
6	1.485	27.68	9.83	37.51	56.00	18.49	6.85	16.68	46.00	29.32	PASS



Neutral:



Final Data List

NO.	Freq. [MHz]	QP Reading [dBμV]	Factor [dB]	QP Value [dBμV]	QP Limit [dBμV]	QP Margin [dB]	AV Reading [dBμV]	AV Value [dBμV]	AV Limit [dBμV]	AV Margin [dB]	Verdict
1	0.155	31.06	9.81	40.87	65.73	24.86	10.57	20.38	55.73	35.35	PASS
2	0.425	25.18	9.81	34.99	57.35	22.36	6.69	16.50	47.35	30.85	PASS
3	0.545	24.59	9.81	34.40	56.00	21.60	4.75	14.56	46.00	31.44	PASS
4	0.865	24.29	9.82	34.11	56.00	21.89	6.02	15.84	46.00	30.16	PASS
5	1.095	27.04	9.83	36.87	56.00	19.13	5.16	14.99	46.00	31.01	PASS
6	1.475	29.04	9.83	38.87	56.00	17.13	8.24	18.07	46.00	27.93	PASS



7.2. RADIATED ELECTROMAGNETIC DISTURBANCE

7.2.1. LIMITS

Frequency	Limits for loop diameter dB(μ A)*		
	2 m	3 m	4 m
9 kHz-70 kHz	88	81	75
70 kHz-150 kHz	88-58**	81-51**	75-45**
150 kHz-3.0 MHz	58-22**	51-15**	45-9**
3.0 MHz-30 MHz	22	15-16***	9-12***
* At the transition frequency, the lower limit applies. ** Decreasing linearly with the logarithm of the frequency. *** Increasing linearly with the logarithm of the frequency.			

7.2.2. TEST PROCEDURE

The EUT and support equipment are positioned in the centre of loop antenna system (LAS). The LAS consists of three circular, mutually perpendicular large-loop antennas (LLAs), having a diameter of 2 m, supported by a non-metallic base. A 50 Ω coaxial cable between the current probe of an LLA and the coaxial switch, and between this switch and the measuring equipment, shall have surface transfer impedance smaller than 10 m Ω /m at 100 kHz and 1 m Ω /m at 10 MHz. The distance between the outer diameter of the loop antenna system and nearby objects, such as floor and walls, shall be at least 0.5 m as per CISPR 15/ EN 55015.

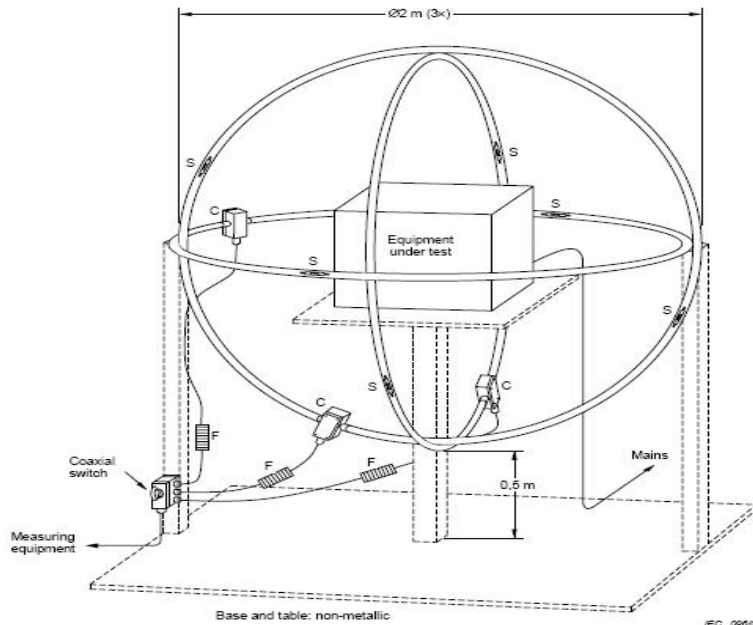
The induced current in the loop antenna is measured by means of a current probe (1 V/A) and the CISPR measuring receiver. By means of a coaxial switch, the three field directions (X, Y, Z) can be measured in sequence.

The receiver scanned from 9 kHz to 30 MHz for emissions in each of the test modes, and recorded at least the six highest emissions. Each value shall comply with the requirement given.

The test data of the worst-case condition(s) was recorded.

Note: Test Software Name: Tonscend,JS32-RE/4.0.0.0.

7.2.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.2.4. TEST RESULT

Product name	LED filament lamp	Antenna Pole	X, Y, Z
Model	A60-8W	Antenna Diameter	2 m
Test Mode	Lighting	Detector Function	Peak
Environmental Conditions	24.2°C, 55 % RH, 101.5 kPa	6 dB Bandwidth	200 Hz/9 kHz
Tested By	ZZY	Test Result	Pass

Note:

Freq. = Emission frequency in MHz

Reading level (dB μ A) = Receiver reading

Corr. Factor (dB) = Antenna factor + Cable loss

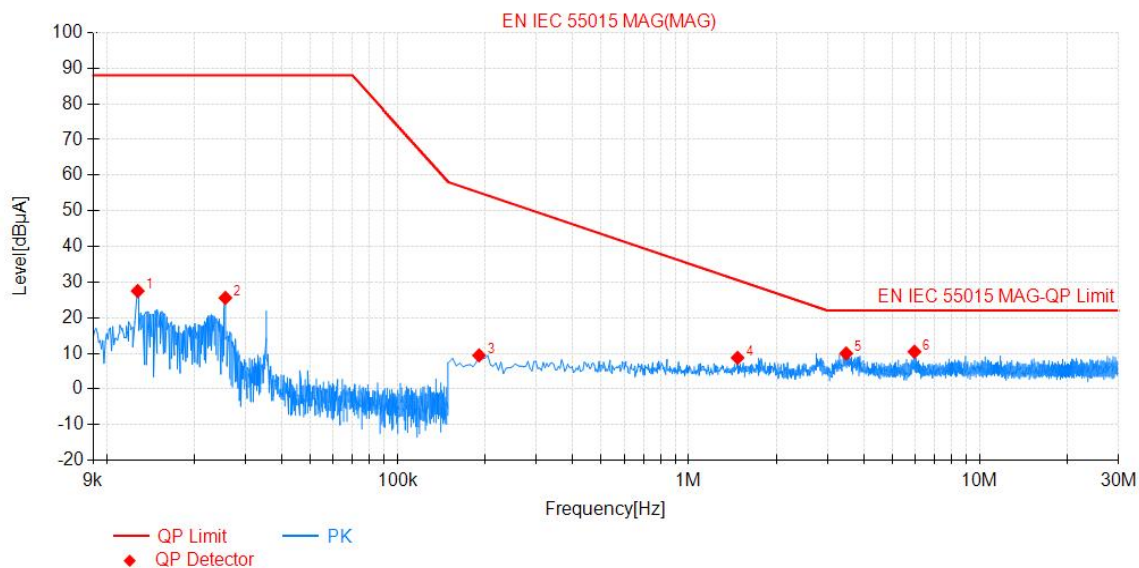
Measurement (dB μ A) = Reading level (dB μ A) + Corr. Factor (dB)

Limit (dB μ A) = Limit stated in standard

Over Limit (dB) = Measurement (dB μ A) – Limit (dB μ A) QP = Quasi-Peak

Please refer to the following diagram:

X:

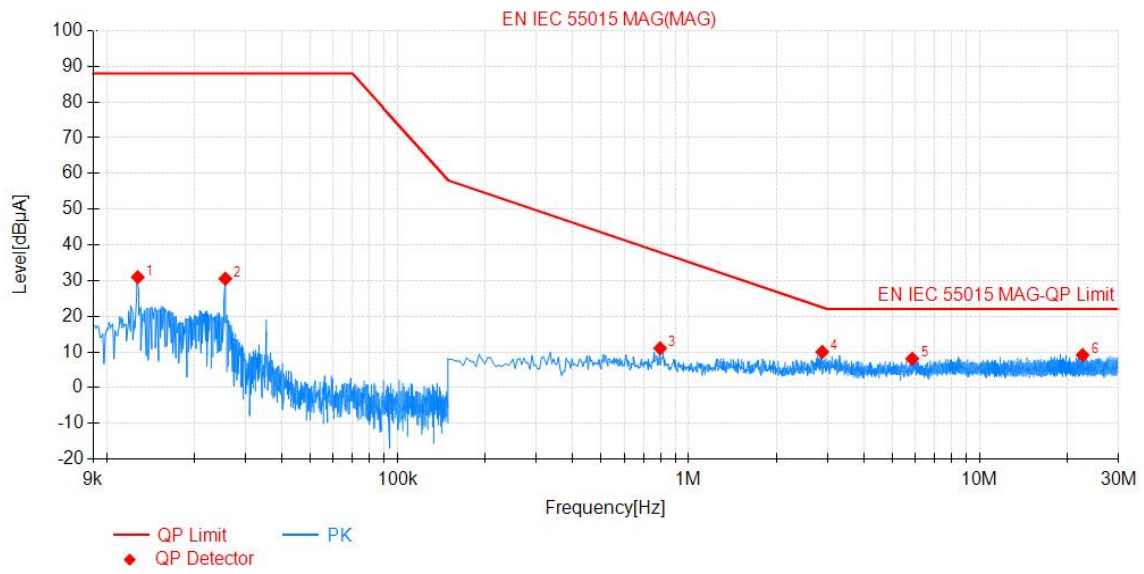


Final Data List

NO.	Freq. [MHz]	Factor [dB]	QP Value [dBμA]	QP Limit [dBμA]	QP Margin [dB]	Verdict
1	0.015	1.08	21.25	88.00	66.75	PASS
2	0.036	1.10	19.10	88.00	68.90	PASS
3	0.515	1.50	7.27	43.19	35.92	PASS
4	1.568	1.32	7.95	29.80	21.85	PASS
5	3.516	1.54	9.87	22.00	12.13	PASS
6	10.338	2.11	10.51	22.00	11.49	PASS



Y:

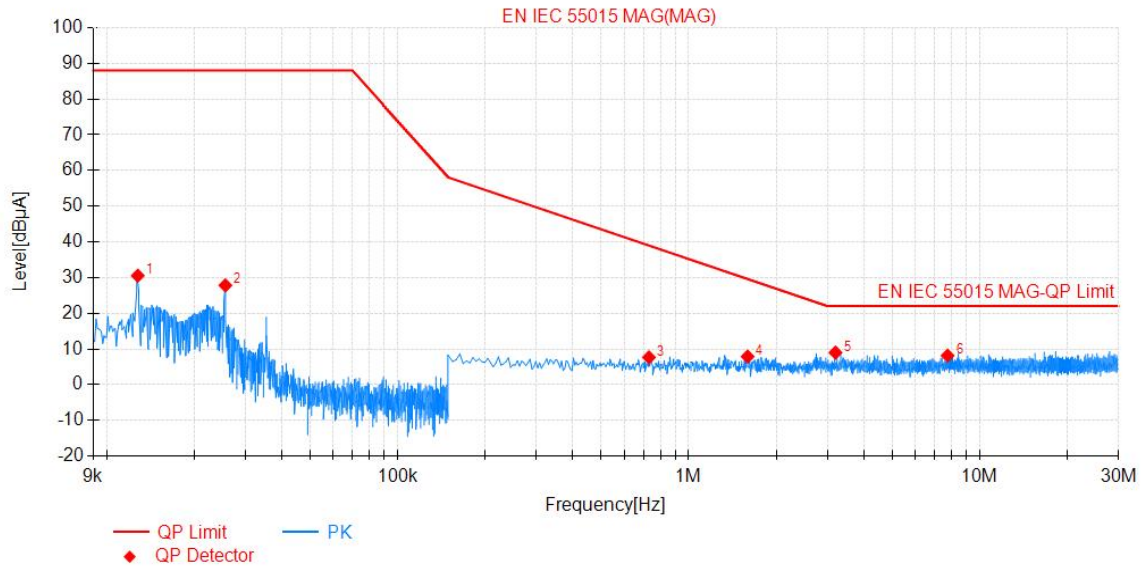


Final Data List

NO.	Freq. [MHz]	Factor [dB]	QP Value [dBμA]	QP Limit [dBμA]	QP Margin [dB]	Verdict
1	0.015	1.08	21.00	88.00	67.00	PASS
2	0.036	1.10	19.23	88.00	68.77	PASS
3	0.159	1.26	8.32	57.30	48.98	PASS
4	1.334	1.28	7.68	31.74	24.06	PASS
5	3.651	1.56	8.87	22.00	13.13	PASS
6	10.302	2.11	10.25	22.00	11.75	PASS



Z:



Final Data List

NO.	Freq. [MHz]	Factor [dB]	QP Value [dBμA]	QP Limit [dBμA]	QP Margin [dB]	Verdict
1	0.015	1.08	21.42	88.00	66.58	PASS
2	0.036	1.10	19.53	88.00	68.47	PASS
3	0.474	1.50	8.05	44.17	36.12	PASS
4	1.230	1.26	7.79	32.71	24.92	PASS
5	3.516	1.54	8.46	22.00	13.54	PASS
6	10.064	2.10	11.47	22.00	10.53	PASS



7.3. RADIATED EMISSION MEASUREMENT

7.3.1. LIMITS

FREQUENCY (MHz)	Limit (dB μ V/m) (At 3 m)	Limit (dB μ V/m) (At 10 m)
30 ~ 230	40	30
230 ~ 1000	47	37

Note: 1) The lower limit shall apply at the transition frequencies.

2) Emission level (dB μ V/m) = 20 log Emission level (μ V/m).

7.3.2. TEST PROCEDURE

The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is floor standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.

The antenna was placed at 3 meter away from the EUT. The antenna connected to the spectrum analyzer via a cable and at times a pre-amplifier would be used.

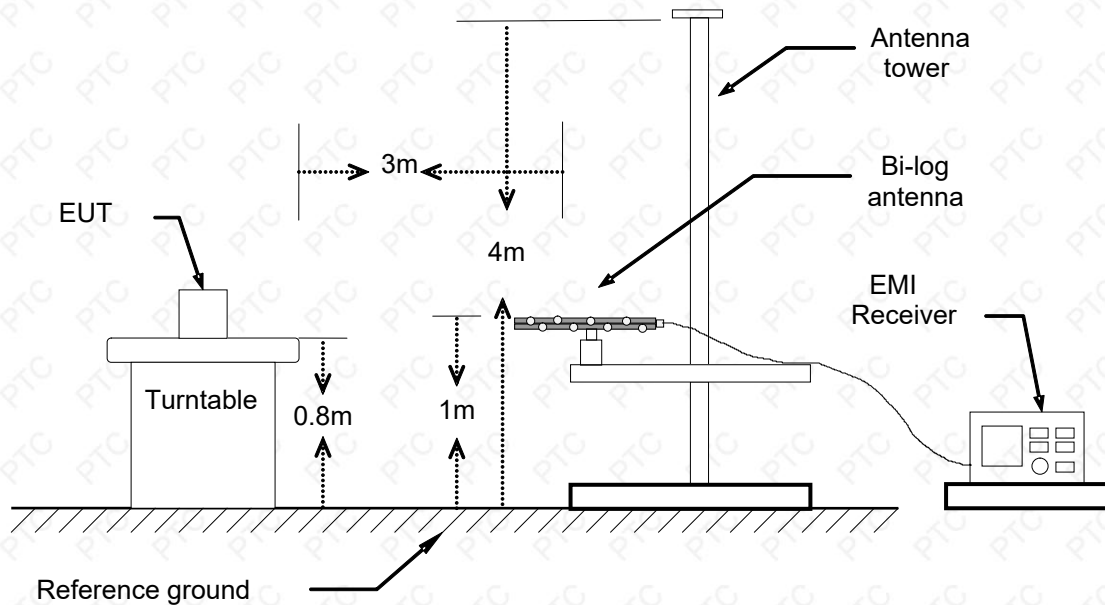
The analyzer / receiver quickly scanned from 30 MHz to 300 MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

During the above scans, the emissions were maximized by cable manipulation. Each modes is measured, recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.

The test data of the worst-case condition(s) was recorded.

Note: Test Software Name:Tonscend,JS32-RE/4.0.0.3.

7.3.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration

7.3.4. TEST RESULT

Product name	LED filament lamp	Antenna Distance	3 m
Model	A60-8W	Antenna Pole	Vertical / Horizontal
Test Mode	Lighting	Detector Function	Peak / Quasi-peak
Environmental Conditions	24.5°C, 52 % RH, 101.3 kPa	6 dB Bandwidth	120 kHz
Tested by	ML	Test Result	Pass

Note:

Freq. = Emission frequency in MHz

Reading level (dBμV) = Receiver reading(dBμV)

Corr.Factor (dB/m)=Antenna factor(dB/m)+Cable loss(dB)-Preamp Factor(dB)

Measurement (dBμV/m)=Reading level(dBμV)+ Corr. Factor (dB/m)

Limit (dBμV/m) = Limit stated in standard

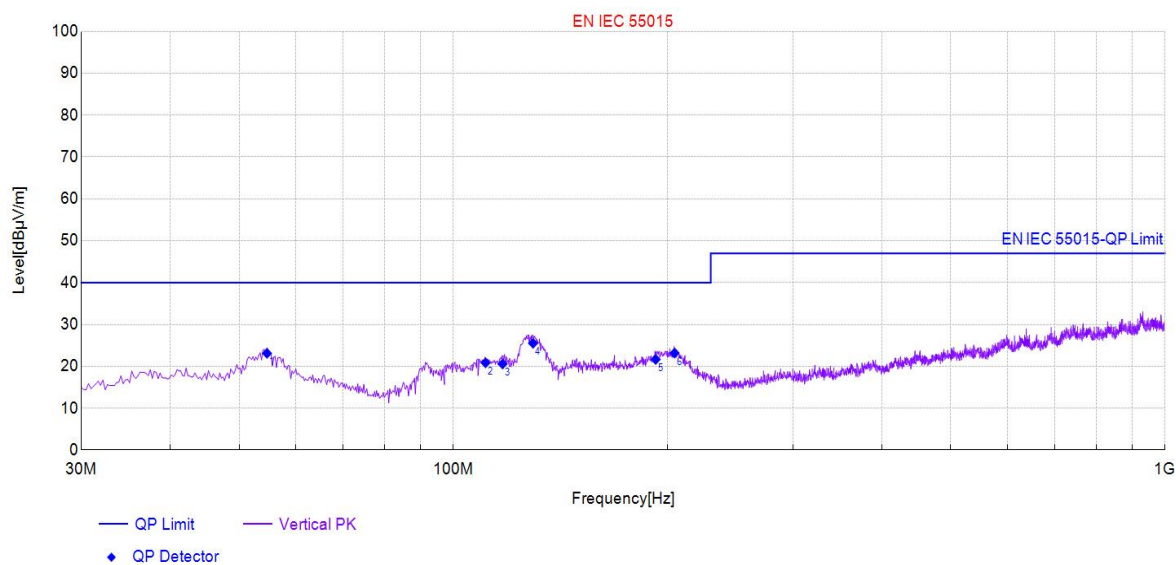
Over Limit (dB) = Measurement (dBμV/m) – Limit (dBμV/m)

QP = Quasi-Peak



Please refer to the following diagram:

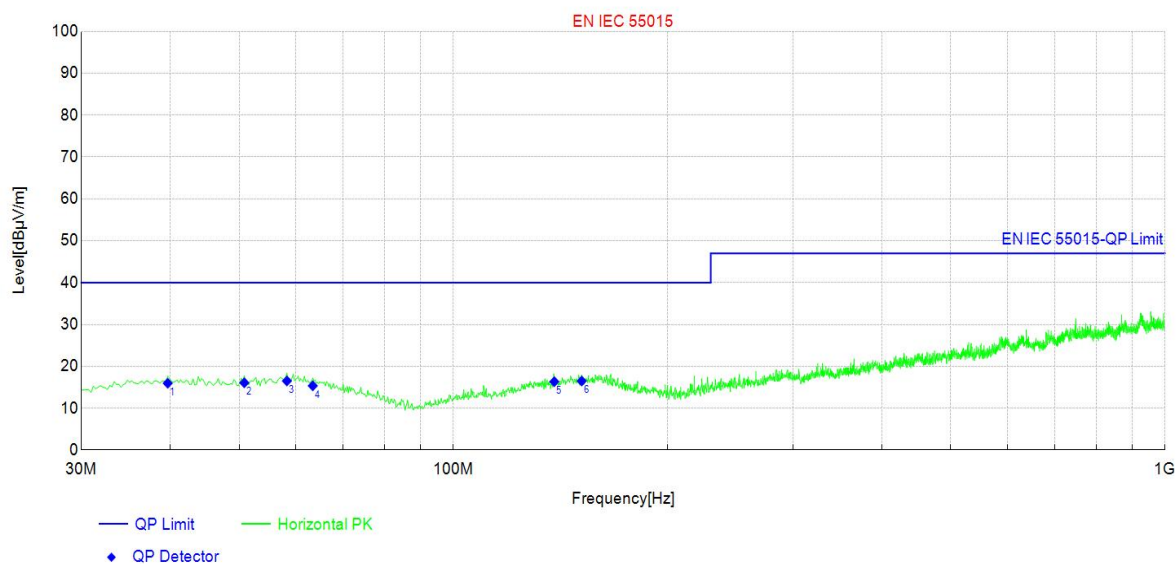
Vertical:



Final Data List[QP]								
NO.	Freq. [MHz]	QP Reading [dBμV]	Factor [dB/m]	QP Value [dBμV/m]	QP Limit [dBμV/m]	QP Margin [dB]	Polarity	Verdict
1	54.74	33.17	-10.05	23.12	40.00	16.88	Vertical	PASS
2	111.00	33.97	-13.11	20.86	40.00	19.14	Vertical	PASS
3	117.30	33.25	-12.67	20.58	40.00	19.42	Vertical	PASS
4	129.43	36.85	-11.33	25.52	40.00	14.48	Vertical	PASS
5	192.48	33.96	-12.29	21.67	40.00	18.33	Vertical	PASS
6	204.60	36.03	-12.85	23.18	40.00	16.82	Vertical	PASS



Horizontal:



Final Data List[QP]								
NO.	Freq. [MHz]	QP Reading [dBμV]	Factor [dB/m]	QP Value [dBμV/m]	QP Limit [dBμV/m]	QP Margin [dB]	Polarity	Verdict
1	39.70	26.5	-10.53	15.97	40.00	24.03	Horizontal	PASS
2	50.86	26.04	-9.95	16.09	40.00	23.91	Horizontal	PASS
3	58.37	26.74	-10.21	16.53	40.00	23.47	Horizontal	PASS
4	63.47	26.13	-10.76	15.37	40.00	24.63	Horizontal	PASS
5	138.64	26.65	-10.29	16.36	40.00	23.64	Horizontal	PASS
6	151.49	26.07	-9.56	16.51	40.00	23.49	Horizontal	PASS

7.4. HARMONICS CURRENT MEASUREMENT

7.4.1. LIMITS OF HARMONICS CURRENT MEASUREMENT

Limit for Class A equipment	
Harmonics Order N	Max. permissible harmonics current A
Odd harmonics	
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
$15 \leq n \leq 39$	$0.15 \times (15/n)$
Even harmonics	
2	1.08
4	0.43
6	0.30
$8 \leq n \leq 40$	$0.23 \times 8/n$

Limit for Class D equipment		
Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
Odd Harmonics only		
3	3.4	2.30
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
13	0.30	0.21
$15 \leq n \leq 39$ (odd harmonics only)	$3.85/n$	$0.15 \times (15/n)$

Limit for Class C equipment ^a	
Harmonics Order n	Max. permissible harmonics current expressed as a percentage of the input current at the fundamental frequency A
2	2
3	27 ^b
5	10
7	7
9	5
$11 \leq n < \leq 39$ (odd harmonics only)	3

^a:For some Class C products, other emission limits apply (see EN IEC 61000-3-2 7.4).

^b:The limit is determined based on the assumption of modern lighting technologies having power factors of 0,90 or higher

Note: Class A, B, C and D are classified according to item 7.4.2.of this report

7.4.2. TEST PROCEDURES

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic. The classification of EUT is according to section 5 of EN IEC 61000-3-2.

The EUT is classified as follows:

Class A:

Equipment not specified as belonging to Class B, C or D shall be considered as Class A equipment.

Some examples of Class A equipment are:

- balanced three-phase equipment;
- household appliances, excluding those specified as belonging to Class B, C or D;
- vacuum cleaners;
- high pressure cleaners;
- tools, excluding portable tools;
- independent phase control dimmers;
- audio equipment;
- professional luminaires for stage lighting and studios.

NOTE 1 Equipment that can be shown to have a significant effect on the supply system might be reclassified in a future edition of this document, taking into account the following factors:

- number of pieces of equipment in use;
- duration of use;
- simultaneity of use;
- power consumption;
- harmonic spectrum, including phase.

Class B:

- portable tools;
- arc welding equipment which is not professional equipment.

Class C:

- lighting equipment.

Class D:

Equipment having a specified power less than or equal to 600 W according to 6.3.2, of the following types:

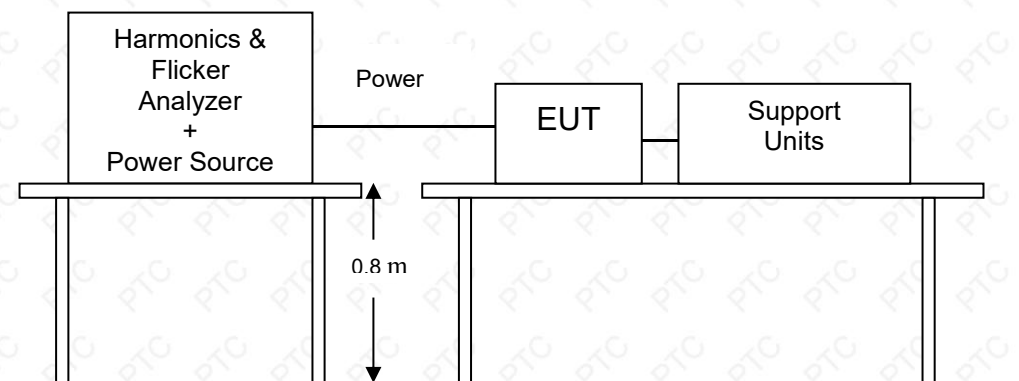
- personal computers and personal computer monitors;

- television receivers;
- refrigerators and freezers having one or more variable-speed drives to control compressor motor(s).

NOTE 2 Class D limits are reserved for equipment that, by virtue of the factors listed in note 1 , can be shown to have a pronounced effect on the public electricity supply system.

The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

7.4.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.4.4. TEST RESULT

Product	LED filament lamp	Tested by	QJR
Model	A60-8W	Limits	Class ☐ A ☐ B ☒ C ☐ D
Test Mode	Lighting	Observation Period (Tp)	2.5 mins
Environmental Conditions	24.3°C, 54.1 % RH, 101.1 kPa	Test Result	Pass

Note: 1) Limits classified according to item 7.4.2 of this report.



Report No.: PTC25060416601E-EM01

Please refer to the following test data:

Test Result: PASS

THC(A): 0.033 I-THD(%): 94.1 POHC(A): N/A POHC Limit(A): N/A

Highest parameter values during test:

V_RMS (Volts):	221.14	Frequency(Hz):	50.00
I_Peak (Amps):	0.164	I_RMS (Amps):	0.048
I_Fund (Amps):	0.035	Crest Factor:	3.466
Power (Watts):	7.6	Power Factor:	0.717

Harm#	Harms(avg)	100%Limit	%of Limit	Status
3	0.025	0.030	83.5	Pass
5	0.012	0.021	58.3	Pass

Waveform fails phase angle spec :

Peak current (Ipeak) = -164.20 mA (164.2 mA absolute)

Peak current max. phase angle = 51 degree (Pos) Pass

Min. Current at 60 deg (I_60) = 9.23 mA (Neg) Limit = 8.21 mA Pass

Min. Current at 90 deg (I_90) = -77.71 mA (Neg) Limit = 8.21 mA Pass

7.5. VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

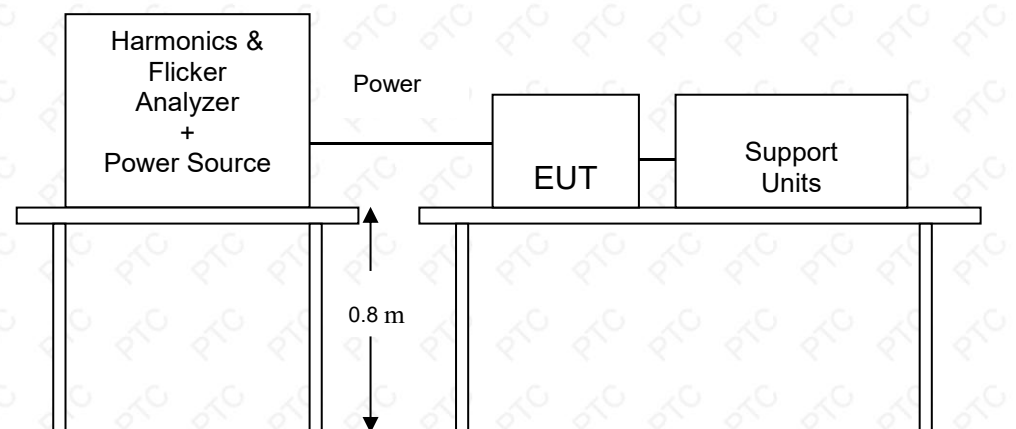
7.5.1. LIMITS OF VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

TEST ITEM	LIMIT	REMARK
P_{st}	1.0	P_{st} means short-term flicker indicator.
P_{lt}	0.65	P_{lt} means long-term flicker indicator.
T_{dt} (ms)	500	T_{dt} means maximum time that dt exceeds 3 %.
d_{max} (%)	4/6/7 %	d_{max} means maximum relative voltage change.
dc (%)	3.3 %	dc means relative steady-state voltage change

7.5.2. TEST PROCEDURE

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under lighting operating conditions. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

7.5.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.5.4. TEST RESULT

Product	LED filament lamp	Tested by	QJR
Model	A60-8W	Observation Period (Tp)	10 mins
Test Mode	Lighting	Test Result	Pass
Environmental Conditions	24.3°C, 54.1 % RH, 101.1 kPa		



Report No.: PTC25060416601E-EM01

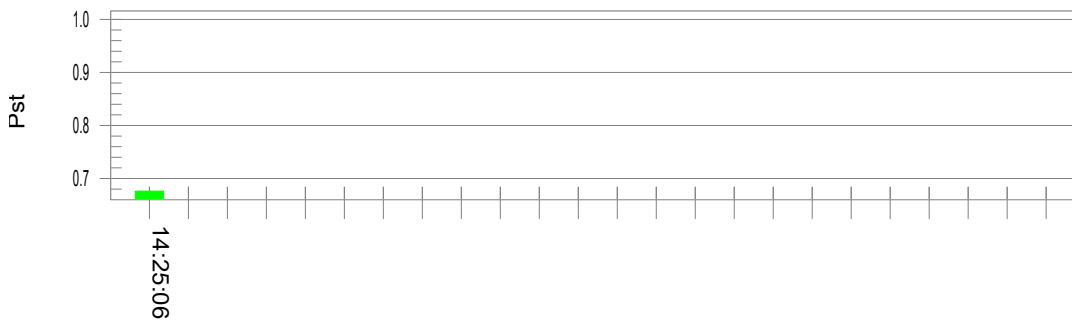
Please refer to the following test data:

Test Result: Pass

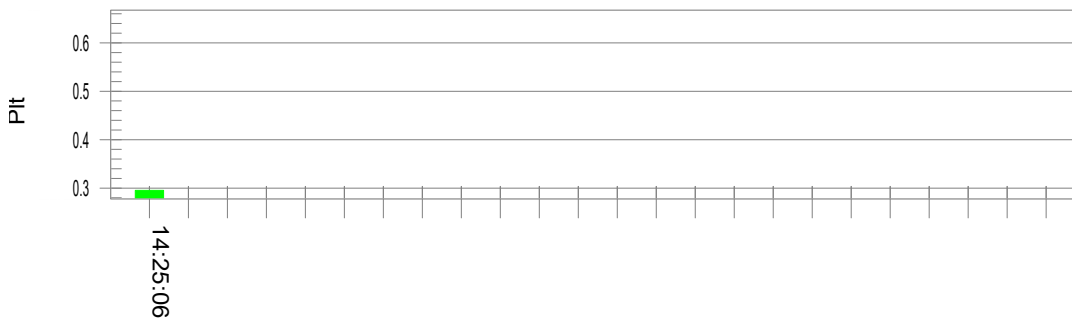
Status: Test Completed

Pst_i and limit line

European Limits



Plt and limit line



Parameter values recorded during the test:

Vrms at the end of test (Volt):	220.75			
T-max (mS):	0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	-2.59	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.676	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.295	Test limit:	0.650	Pass



8. IMMUNITY TEST

8.1. GENERAL DESCRIPTION

Product Standard	EN 61547	
	Test Type	Minimum Requirement
Basic Standard, Specification, and Performance Criterion required	IEC 61000-4-2	Electrostatic Discharge – ESD: ±8 kV air discharge, ±4 kV Contact discharge, Performance Criterion B
	IEC 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80 ~1000 MHz, 3 V/m, 80 % AM(1 kHz), Performance Criterion A
	IEC 61000-4-4	Electrical Fast Transient/Burst - EFT, Power line: ±1 kV, Signal line: ±0.5 kV, Performance Criterion B
	IEC 61000-4-5	Surge Immunity Test: 1.2/50 µs Open Circuit Voltage, 8 /20 µs Short Circuit Current, Power Port ~ Line to line: ±0.5 kV, Line to ground: ±1 kV (to self-ballasted lamps and semi-luminaires; luminaires and independent auxiliaries which are less than or equal to 25 W) Power Port ~ Line to line: ±1 kV, Line to ground: ±2 kV (to luminaires and independent auxiliaries which are more than 25 W) Signal Port : ±0.5 kV Performance Criterion B
	IEC 61000-4-6	Conducted Radio Frequency Disturbances Test –CS: 0.15 ~ 80 MHz, 3 Vrms, 80 % AM, 1 kHz, Performance Criterion A
	IEC 61000-4-8	Power frequency magnetic field immunity test 50 Hz, 3 A/m Performance Criterion A
	IEC 61000-4-11	Voltage Dips and Interruptions: i) 70 % reduction for 10 period, Performance Criterion C ii) 0 % reduction for 0.5 period Performance Criterion B



8.2. GENERAL PERFORMANCE CRITERIA DESCRIPTION

Criteria A:	During the test no change of the luminous intensity shall be observed and the regulating control, if any, shall operate during the test as intended.
Criteria B:	During the test the luminous intensity may change to any value. After the test the luminous intensity shall be restored to its initial value within 1 min. Regulating controls need not function during the test, but after the test the mode of the control shall be the same as before the test provided that during the test no mode changing commands were given.
Criteria C:	During and after the test any change of the luminous intensity is allowed and the lamp(s) may be extinguished. After the test, within 30 min, all functions shall return to normal. if necessary by temporary interruption of the mains supply and/or operating the regulating control. Additional requirement for lighting equipment incorporating a starting device: After the test the lighting equipment is switched off. After half an hour it is switched on again. The lighting equipment shall start and operate as intended.



8.3. ELECTROSTATIC DISCHARGE (ESD)

8.3.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-2
Discharge Impedance:	330 Ω
Charging Capacity:	150 pF
Discharge Voltage:	Air Discharge: ± 8 kV (Direct) Contact Discharge: ± 4 kV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	20 times at each test point (10 times at Positive & 10 times at Negative)
Discharge Mode:	1 time/s
Performance Criterion:	B

8.3.2. TEST PROCEDURE

The discharges shall be applied in two ways:

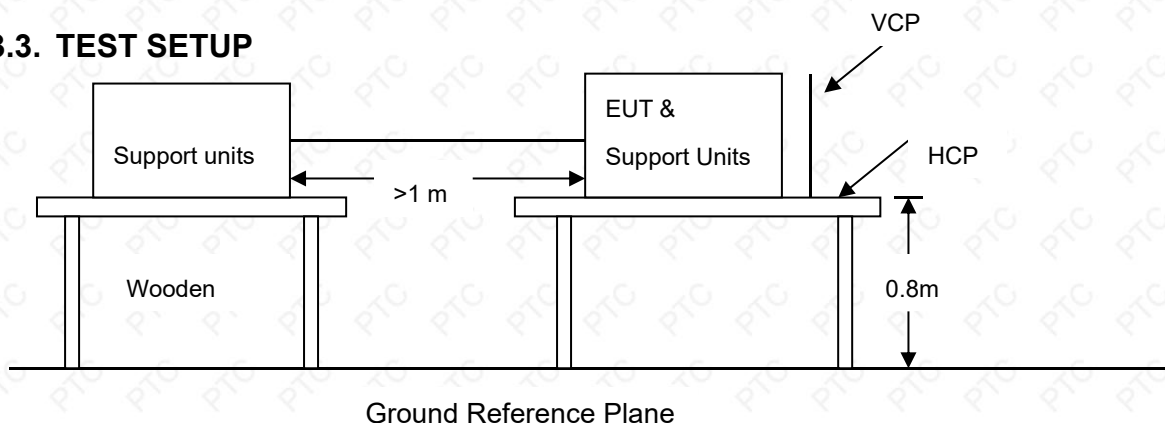
- Contact discharges to the conductive surfaces and coupling planes:
Twenty dischargers (10 with positive and 10 with negative polarity) shall be applied on each accessible metallic part of the enclosure, terminals are excluded. In case of a non-conductive enclosure, dischargers shall be applied on the horizontal or vertical coupling planes. Test shall be performed at a maximum repetition rate of one discharge per second.
- Air discharges at slots and apertures and insulating surfaces:
On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

The basic test procedure was in accordance with IEC 61000-4-2:

- The EUT was located 0.1 m minimum from all side of the HCP (dimensions 1.6 m x 0.8 m).
- The support units were located another table 30 cm away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10cm with EUT.
- The time interval between two successive single discharges was at least 1 second.

- d) Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- e) Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- f) At least ten single discharges (in the most sensitive polarity) were applied at the front edge of each HCP opposite the center point of each unit of the EUT and 0.1 meters from the front of the EUT. The long axis of the discharge electrode was in the plane of the HCP and perpendicular to its front edge during the discharge.
- g) At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane (VCP) in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5 m x 0.5 m) was placed vertically to and 0.1 meters from the EUT.

8.3.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Note:

1) TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the ground reference plane (GRP). The GRP consisted of a sheet of aluminum at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system. A horizontal coupling plane (HCP) (1.6 m x 0.8 m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5 mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.



2) FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the ground reference plane by an insulating support of 0.1 meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

8.3.4. TEST RESULT

Product	LED filament lamp	Environmental Conditions	22.1°C, 52 % RH, 101.2 kPa
Model	A60-8W	Tested By	QJR
Test mode	Lighting	Test Result	Pass

Air Discharge					
Test Points	Test Levels	Results			
	± 8 kV	Pass	Fail	Observation	Performance Criterion
Hull 1 Points	☒	☒	☐	Note ☒ A ☐ B ☐ C	B
Gap 6 Points	☒	☒	☐	Note ☒ A ☐ B ☐ C	B

Contact Discharge					
Test Points	Test Levels	Results			
	± 4 kV	Pass	Fail	Observation	Performance Criterion
HCP 4 Points	☒	☒	☐	Note ☒ A ☐ B ☐ C	B
VCP 4 Points	☒	☒	☐	Note ☒ A ☐ B ☐ C	B

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change, and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.



8.4. RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD (RS)

8.4.1. TEST SPECIFICATION

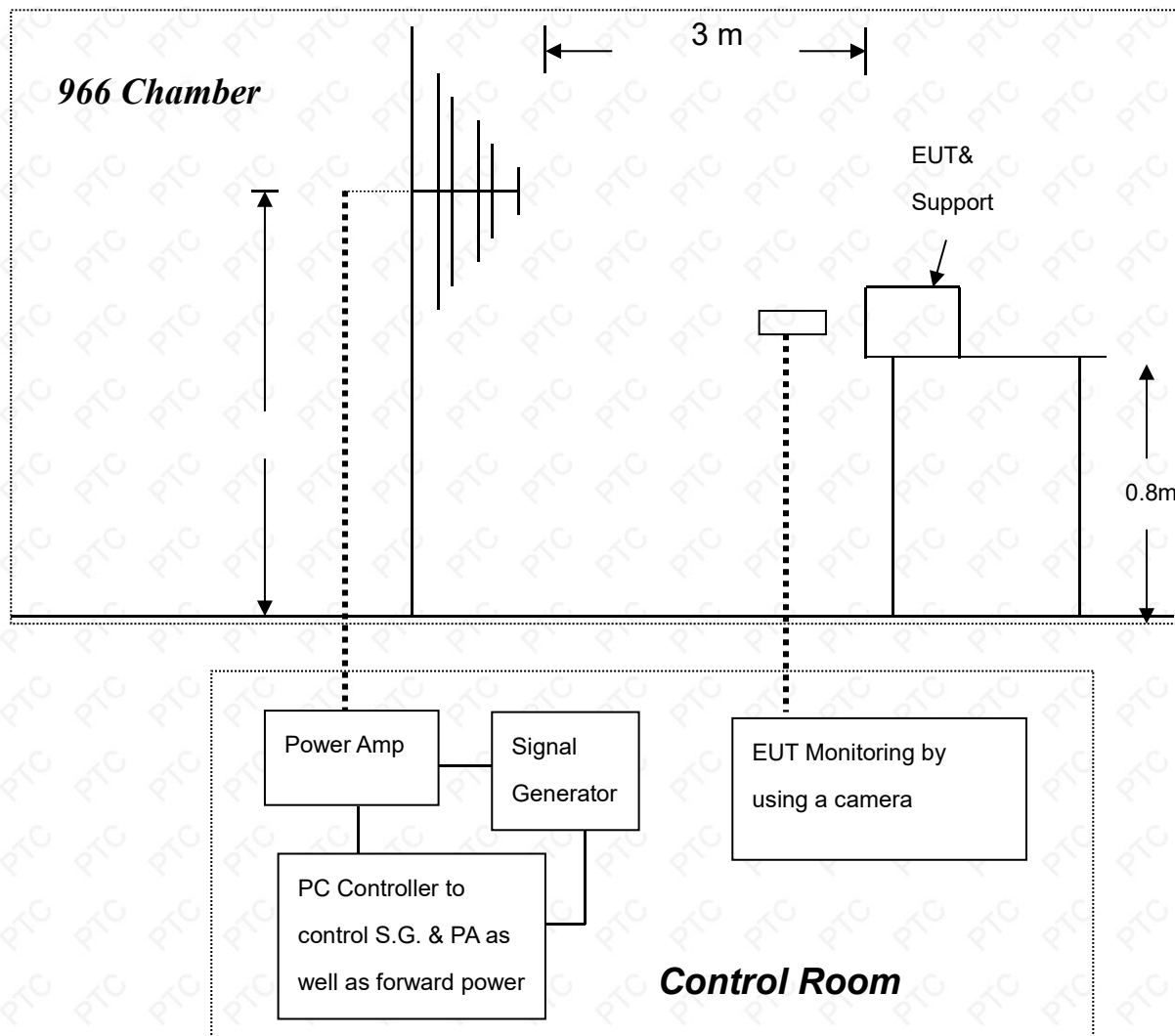
Basic Standard:	IEC 61000-4-3
Frequency Range:	80 MHz ~ 1000 MHz
Field Strength:	3 V/m
Modulation:	1 kHz Sine Wave, 80 %, AM Modulation
Frequency Step:	1 % of preceding frequency value
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m
Performance Criterion:	A

8.4.2. TEST PROCEDURE

The test procedure was in accordance with IEC 61000-4-3

- The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1 kHz sine-wave. The rate of sweep did not exceed 1.5×10^{-3} decade/s, where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value.
- The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

8.4.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Note:

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



8.4.4. TEST RESULT

Product	LED filament lamp	Environmental Conditions	24.1°C, 53 % RH, 101.1 kPa
Model	A60-8W	Tested By	QJR
Test mode	Lighting	Test Result	Pass

Frequency (MHz)	Polarity	Position	Field Strength (V/m)	Observation	Performance Criterion
80 ~ 1000	V&H	Front	3	Note ☒ A ☐ B ☐ C	A
80 ~ 1000	V&H	Rear	3	Note ☒ A ☐ B ☐ C	A
80 ~ 1000	V&H	Left	3	Note ☒ A ☐ B ☐ C	A
80 ~ 1000	V&H	Right	3	Note ☒ A ☐ B ☐ C	A

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change ,and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.



8.5. ELECTRICAL FAST TRANSIENT (EFT)

8.5.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-4
Test Voltage:	Power Line: ± 1 kV Signal/Control Line: ± 0.5 kV
Polarity:	Positive & Negative
Impulse Frequency:	5 kHz
Impulse Wave-shape:	5/50 ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	2 mins
Performance Criterion:	B

8.5.2. TEST PROCEDURE

EUT is placed on a 0.1 m tall wooden table.

EUT operate at normal mode, the transient/burst was 5/50 ns in accordance with IEC 61000-4-4, both positive and negative polarity burst waveform were applied.

The duration time of each test line was 2 minutes.

8.5.3. TEST SETUP

The EUT installed in a representative system as described in section 7 of IEC 61000-4-4.

For the actual test configuration, please refer to the related item – photographs of the test configuration.

**8.5.4. TEST RESULT**

Product	LED filament lamp	Environmental Conditions	24.3°C, 54 % RH, 101.2 kPa
Model	A60-8W	Tested By	QJR
Test mode	Lighting	Test Result	Pass

Test Point	Polarity	Test Level (kV)	Observation	Performance Criterion
L	+/-	1	Note ☒ A ☐ B ☐ C	B
N	+/-	1	Note ☒ A ☐ B ☐ C	B
L – N	+/-	1	Note ☒ A ☐ B ☐ C	B
Signal/Control cable	--	--	--	--

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change, and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.



8.6. SURGE IMMUNITY TEST

8.6.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-5
Wave-Shape:	Combination Wave 1.2/50 μ s Open Circuit Voltage 8/20 μ s Short Circuit Current Power Port ~ Line to line: ± 0.5 kV, Line to ground: ± 1 kV (to self-ballasted lamps and semi-luminaries; luminaires and independent auxiliaries which are less than 25 W)
Test Voltage:	Power Port ~ Line to line: ± 1 kV, Line to ground: ± 2 kV (to luminaires and independent auxiliaries which are more than 25 W)
Surge Input/Output:	Power Line: L-N / L-PE / N-PE
Generator Source Impedance:	2 Ω between networks 12 Ω between network and ground
Polarity:	Positive/Negative
Phase Angle:	90°(positive polarity pulses) / 270°(negative polarity pulses)
Pulse Repetition Rate:	1 time / min.
Number of Tests:	5 positive polarity pulses at the 90° phase angle, and 5 negative polarity pulses at 270° phase angle
Performance Criterion:	B

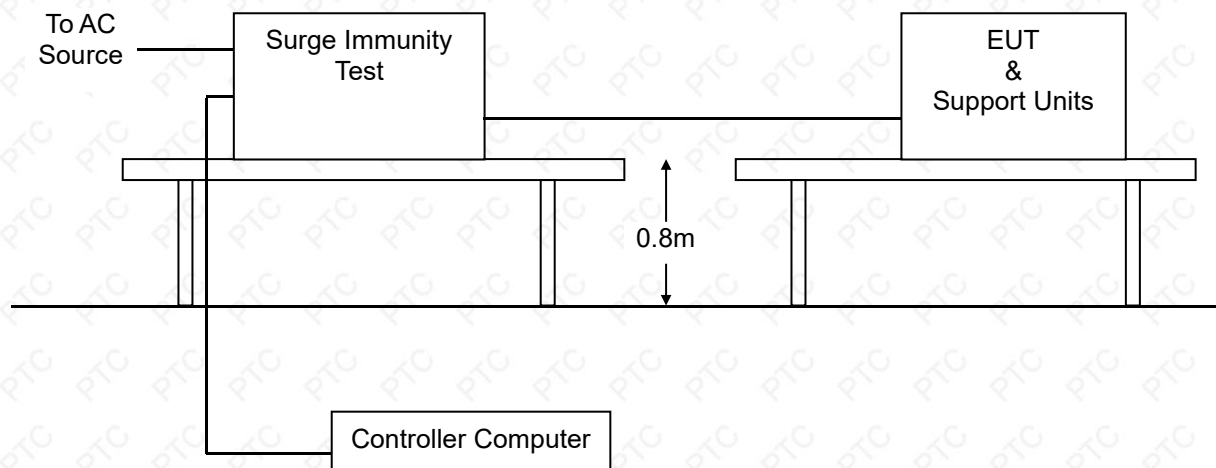
8.6.2. TEST PROCEDURE

EUT is placed on a 0.1 m (table type equipment) / 0.8 m (floor type equipment) tall wooden table.

EUT operate at normal mode, two types of combination wave generator (1.2/50 μ s open-circuit voltage and 8/20 μ s short-circuit current) are applied to the EUT power supply terminals via the capacitive coupling network.

The power cord between the EUT and the coupling/decoupling network shall not exceed 2 m in length.

8.6.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

8.6.4. TEST RESULT

Product	LED filament lamp	Environmental Conditions	24.3°C, 52 % RH, 101.2 kPa
Model	A60-8W	Tested By	QJR
Test mode	Lighting	Test Result	Pass

Test Point	Polarity	Test Level (kV)	Observation	Performance Criterion
L - N	+/-	1	Note ☒ A ☐ B ☐ C	B

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change ,and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.

8.7. CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

8.7.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-6
Frequency Range:	0.15 MHz ~80 MHz
Field Strength:	3 V
Modulation:	1 kHz Sine Wave, 80 %, AM Modulation
Frequency Step:	1 % of preceding frequency value
Coupled cable:	Power Mains, Shielded
Coupling device:	CDN-M3/2 (3 wires/2 wires)
Performance Criterion:	A

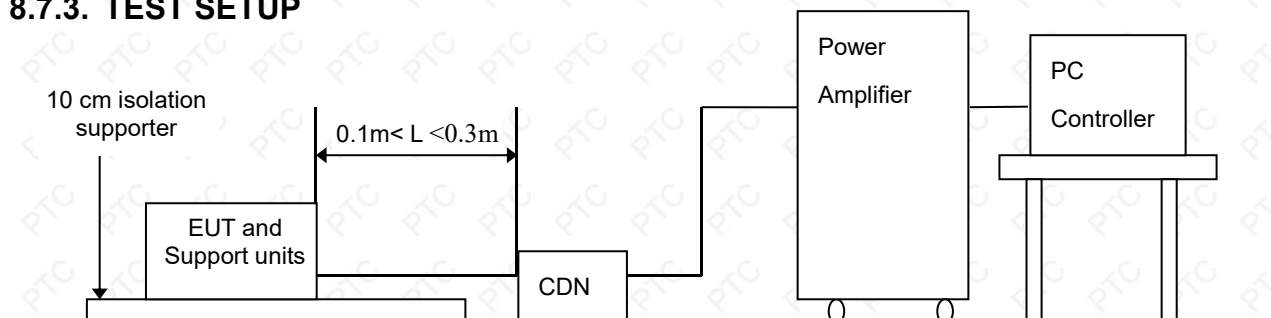
8.7.2. TEST PROCEDURE

The EUT shall be tested within its intended operating and climatic conditions.

The test shall performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50 Ω load resistor.

The frequency range was swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal was modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate was 1.5×10^{-3} decades/s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value the dwell time of the amplitude modulated carrier at each frequency was 0.5 s.

8.7.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration

Note: 1) The EUT is setup 0.1 m above Ground Reference Plane

2) All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

**8.7.4. TEST RESULT**

Product	LED filament lamp	Environmental Conditions	24.1°C, 51 % RH, 101.2 kPa
Model	A60-8W	Tested By	QJR
Test mode	Lighting	Test Result	Pass

Frequency (MHz)	Field Strength (Vrms)	Injected Position	Injection Method	Observation	Performance Criterion
0.15 ~ 80	3	AC Mains	CDN-M2/M3	Note ☒ A ☐ B ☐ C	A

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change, and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.



8.8. POWER FREQUENCY MAGNETIC FIELD

8.8.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-8
Frequency Range:	50 Hz
Field Strength:	1A/m
Observation Time:	5 minutes
Inductance Coil:	Rectangular type, 1 m x 1 m
Performance Criterion:	A

8.8.2. TEST PROCEDURE

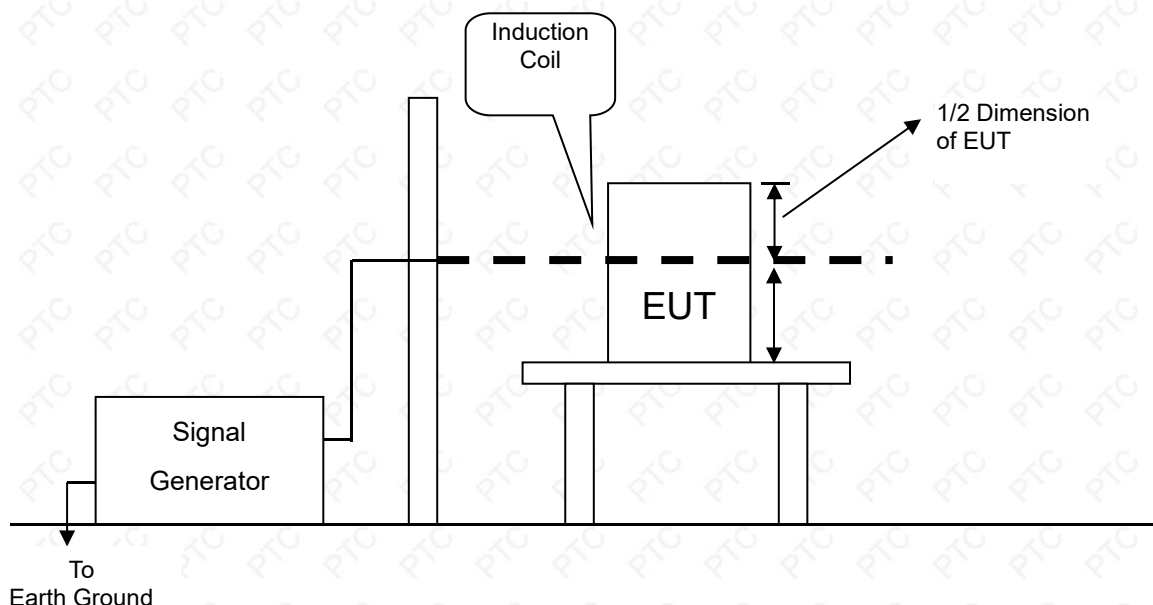
The equipment is configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0.1 m-thick insulating support.

The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.

The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.

The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

8.8.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration
Note:

TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

8.8.4. TEST RESULT

The test only applies to apparatus containing device susceptible to magnetic fields, such as hall elements or magnetic field sensor, so this item isn't applicable to the products.

8.9. VOLTAGE DIP & VOLTAGE INTERRUPTIONS

8.9.1. TEST SPECIFICATION

Basic Standard:	IEC 61000-4-11
Test Duration Time:	3 test events in sequence
Interval Between Event:	10 seconds
Phase Angle:	0°
Test Cycle:	3 times
Performance Criterion:	0% U_T / 0.5 P, Criterion: B 70% U_T / 10 P, Criterion: C

8.9.2. TEST PROCEDURE

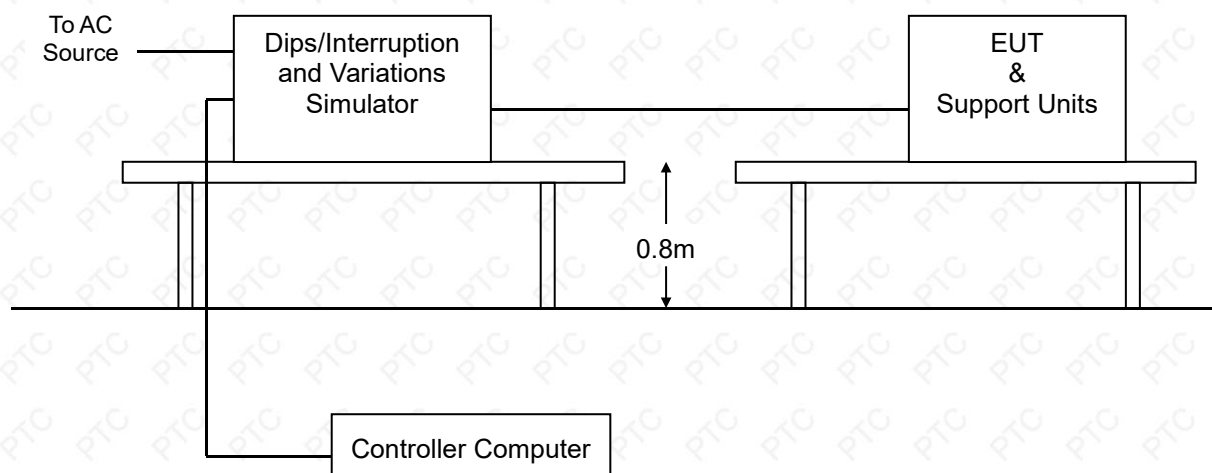
The EUT and support units were located on a wooden table, 0.8 m away from ground floor.

Setting the parameter of tests and then perform the test software of test simulator.

Changes to the voltage level shall occur at 0 degree crossing point in the a.c. voltage waveform.

Record the test result in test record form.

8.9.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

**8.9.4. TEST RESULT**

Product	LED filament lamp	Environmental Conditions	24.3°C, 54 % RH, 101.2 kPa
Model	A60-8W	Tested By	QJR
Test mode	Lighting	Test Result	Pass

Test Power: 230 Vac, 50 Hz			
Voltage (% Reduction)	Duration (Period)	Observation	Performance Criterion
0	0.5	Note ☒ A ☐ B ☐ C	B
70	10	Note ☒ A ☐ B ☐ C	C

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change, and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change, and after the test the luminous intensity can return to normal within 30 min.

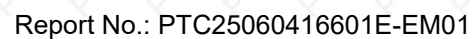
9. PHOTOGRAPHS OF THE TEST CONFIGURATION

CONDUCTED EMISSION TEST



RADIATED ELECTROMAGNETIC EMISSION TEST



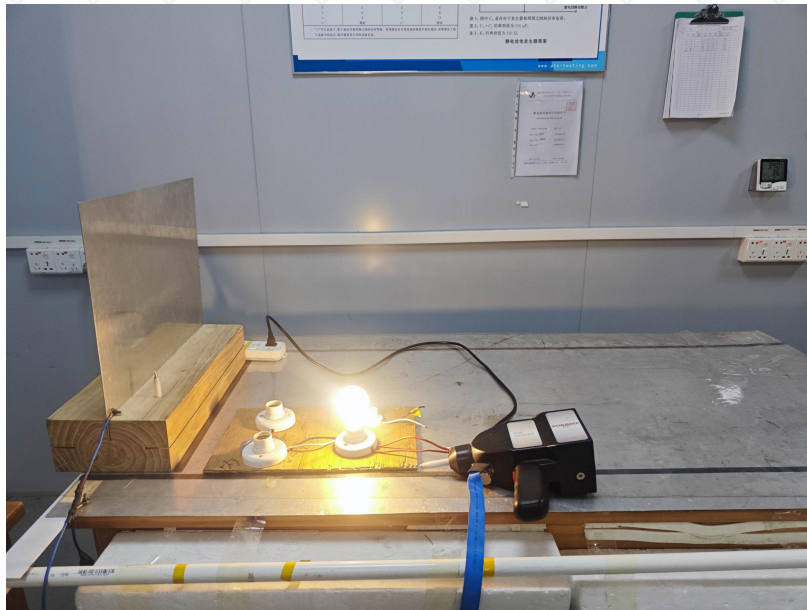


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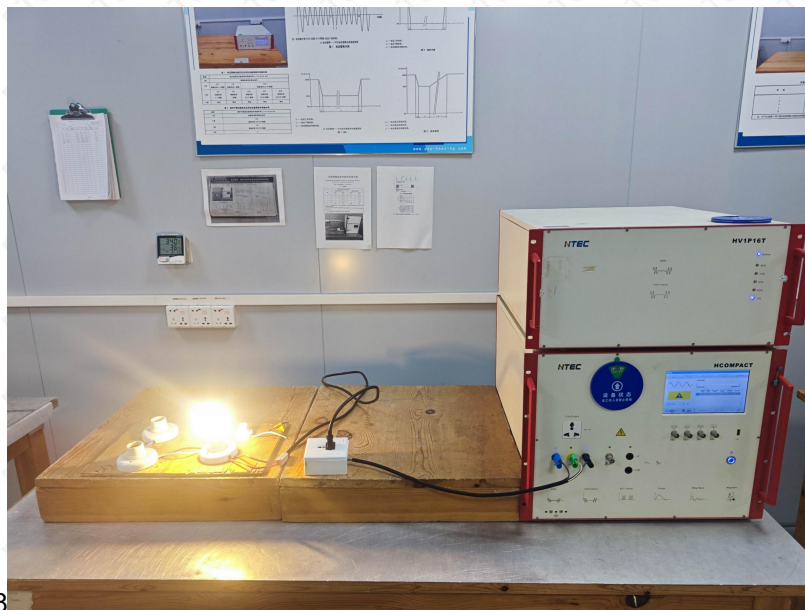


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ESD TEST



EFT TEST

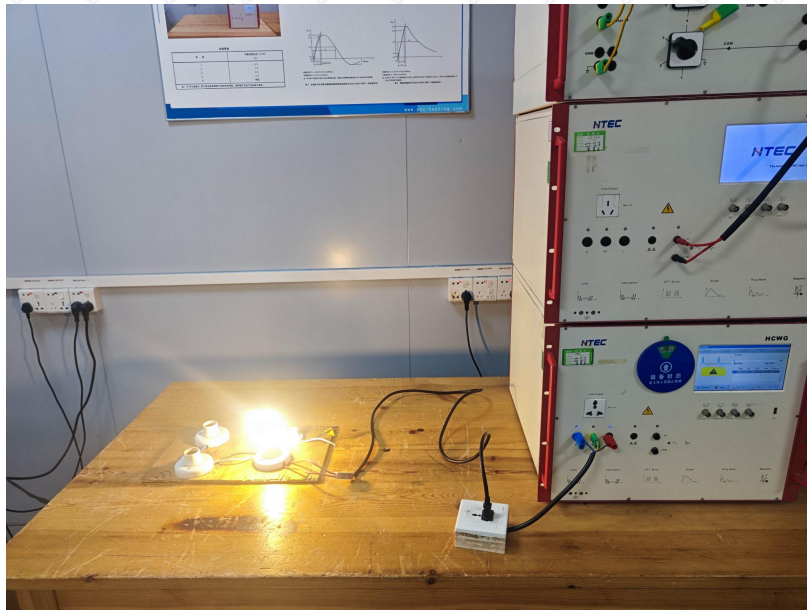


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SURGE TEST



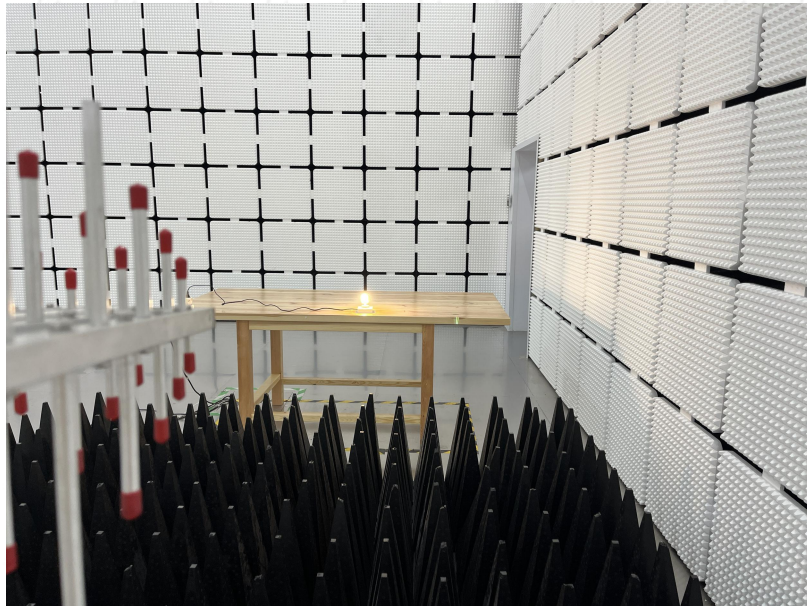
CS TEST



DIPS TEST



RS TEST



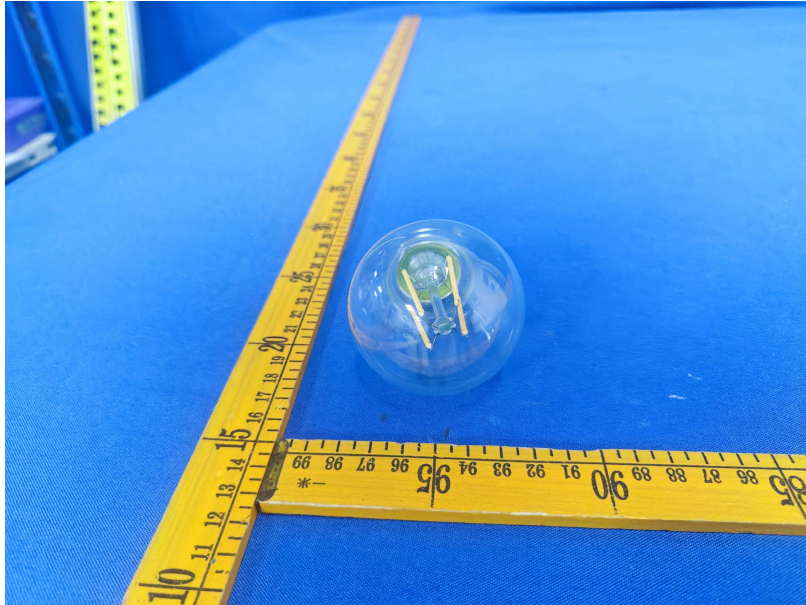
10. PHOTOGRAPHS OF EUT





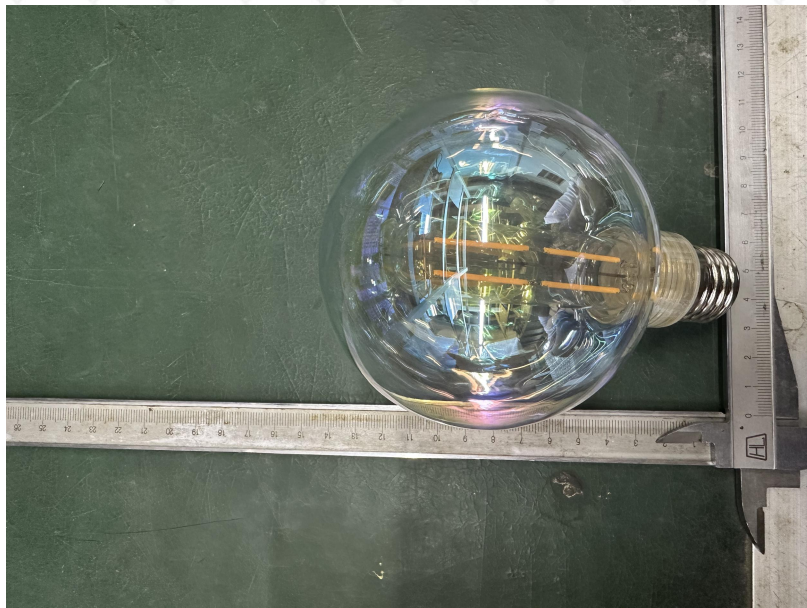
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— End of report —